

A SQUID-BASED BEAM CURRENT MONITOR FOR FAIR / CRYRING



OUTLINE

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- Future Installations at FAIR
- Challenges
- Cryogenic Current Comparator (CCC) principle
- Experimental results for improved sensitivity
- Conclusions and Outlook

CCC for FAIR

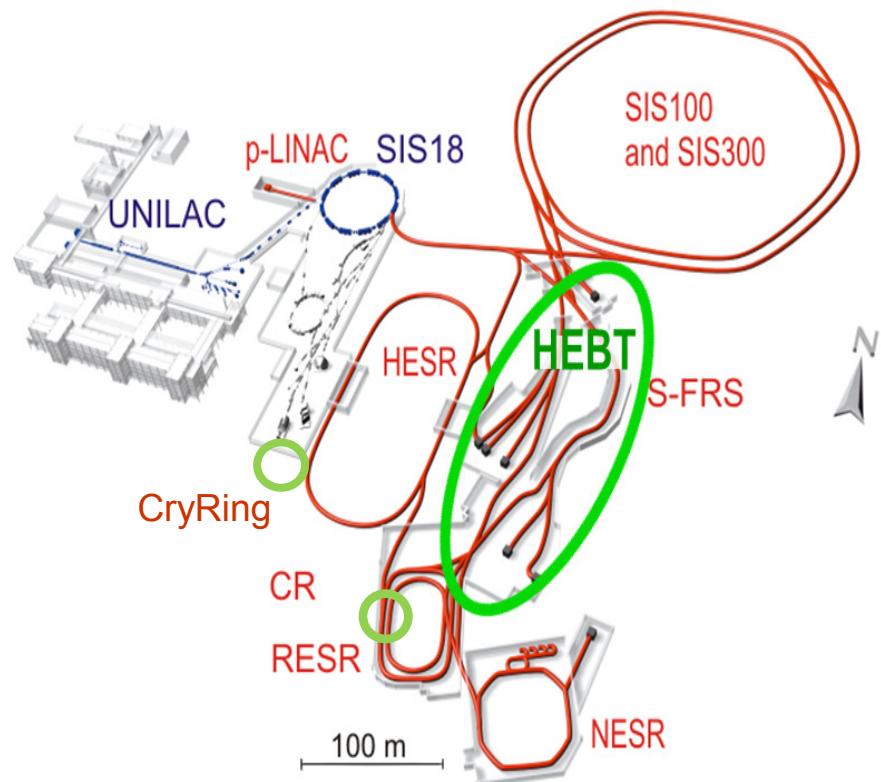


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- Facility of Antiproton and Ion Research (FAIR)
- Beam current measurement in
 - High-Energy Beam Transport (HEBT)-section,
 - Collector Ring (CR)
 - CryRing



CCC for FAIR

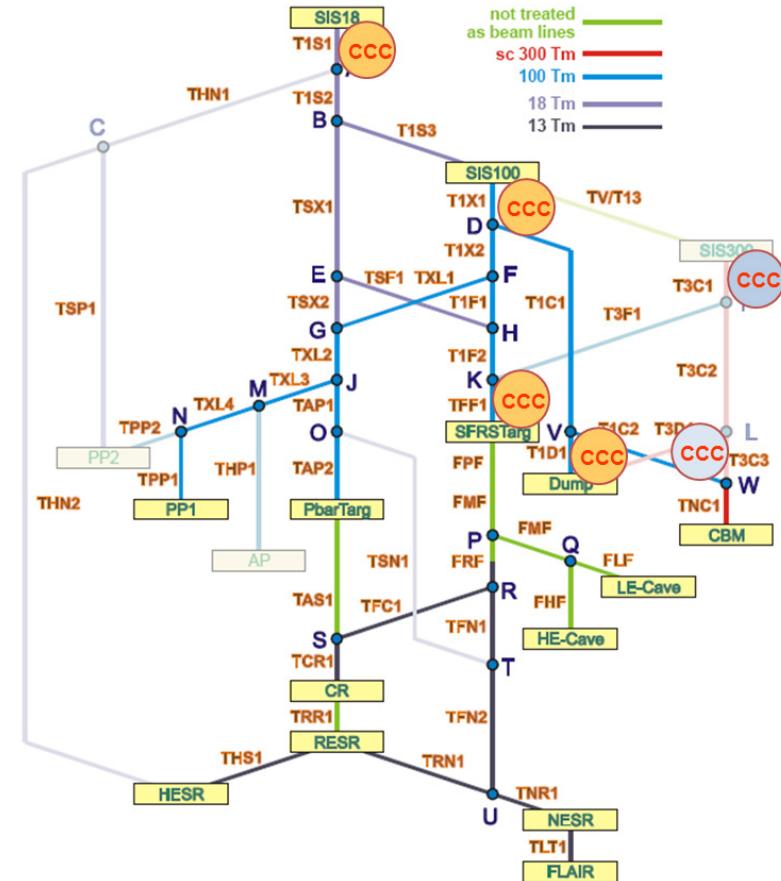


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Beamlne	Location	Extraction type	Particle species	Stage
T1S1	SIS18-SIS100	slow, fast	ions, protons	FAIR Startversion (Modules 0-3)
T1X1	SIS100 extraction	slow, fast	ions, protons	
T1D1	SIS100 → dump	slow	ions, protons	
TFF1	SFRS-Target	slow	ions	
T3C1	SIS300 extraction	slow	ions, protons	
T3D1	SIS300 → dump	slow	ions, protons	Phase B

For all 6 beam lines above:
 minimal Intensity: 10^4 pps
 maximal intensity: 10^{12} pps

Ion	Maximum Beam Current [slow extraction, 1 s]
p	160 nA
U^{28+}	4.5 μ A



Challenge



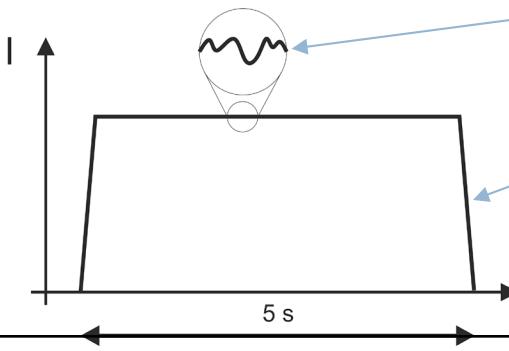
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Beam current measurement

Transport section,
Storage rings

Maximum beam current:
160 nA for (anti-)protons
4.5 μ A for uranium ions U^{28+}

Current pulses with DC-part



Detector requirements

On-line, non-destructive, absolute measurements
easy, linear calibration

goal:
Current resolution < 1nA

High bandwidth incl.DC
High slew rate

CCC-principle



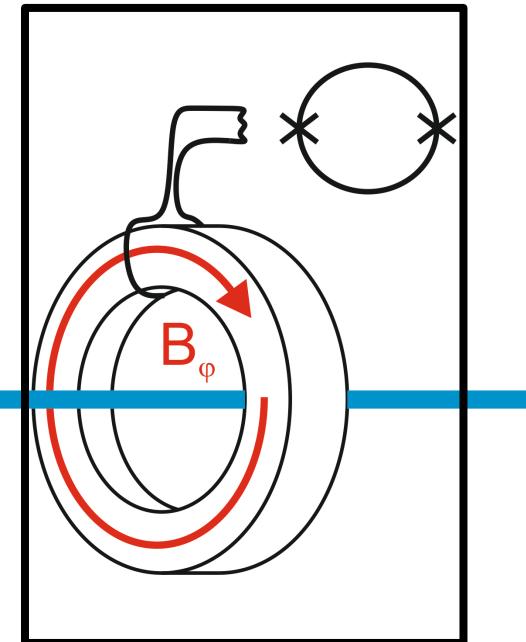
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- Detection of the beam's azimuthal magnetic field
- Superconducting Pick-up coils
 - DC-magnetic field measurements due to flux conservation in closed sc loops
 - Lower noise, because of no hysteresis losses
- DC-Superconducting QUantum Interference Device, (DC-SQUID) acting as current sensor
 - Highly sensitive, low intrinsic noise contribution
- Superconducting Shielding
 - Attenuation of all non-azimuthal magnetic field components

charged
particles



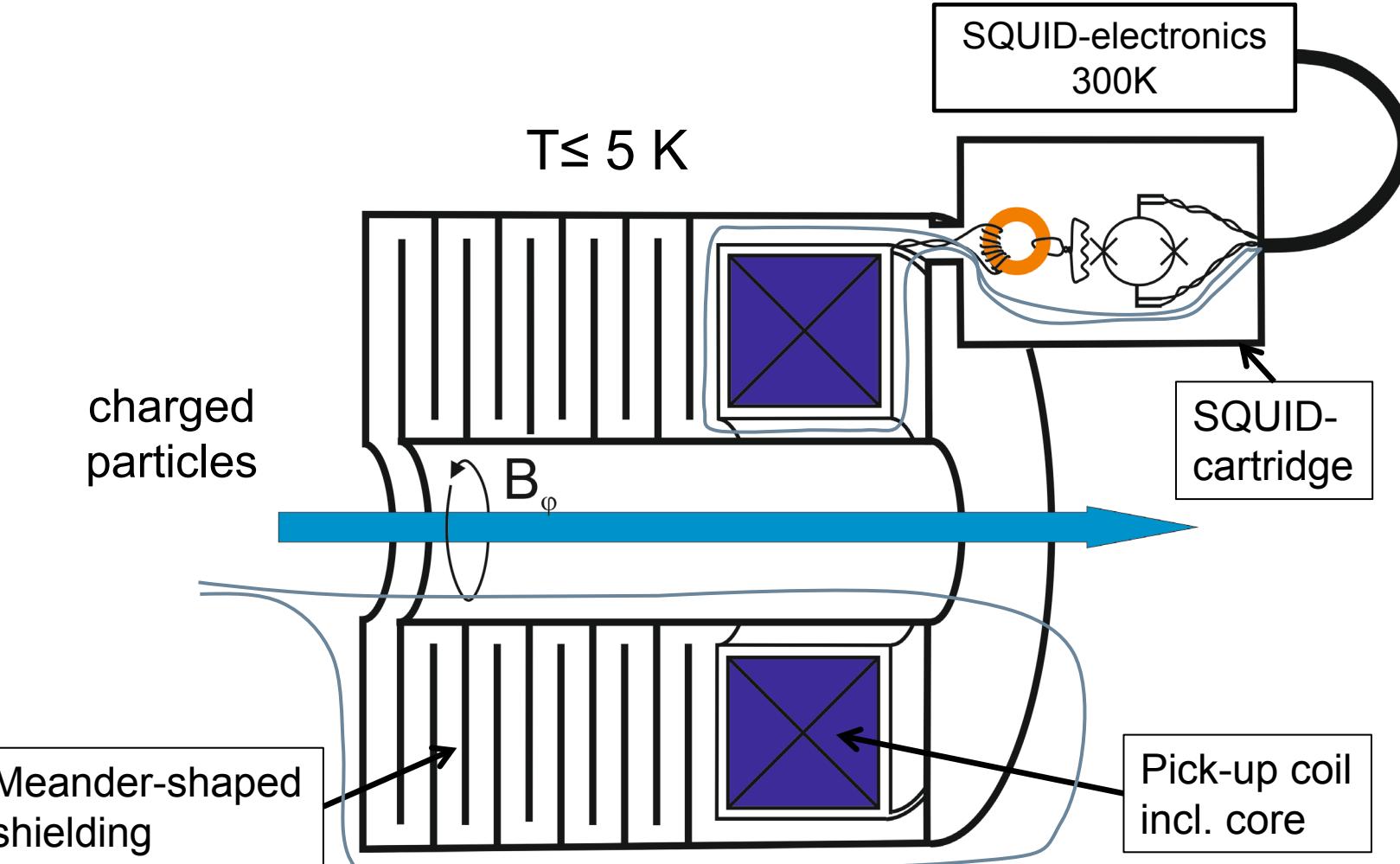
CCC-principle



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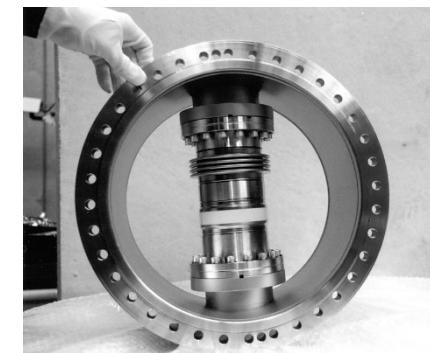
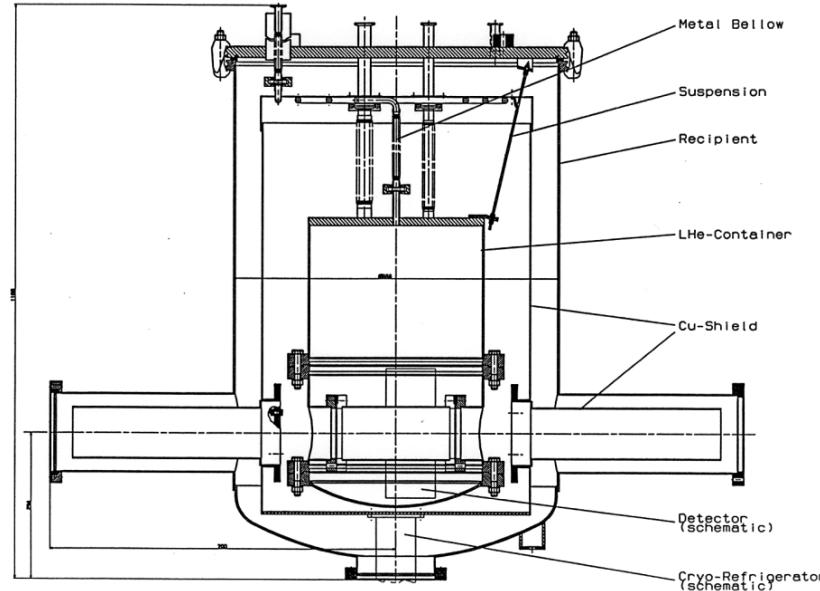
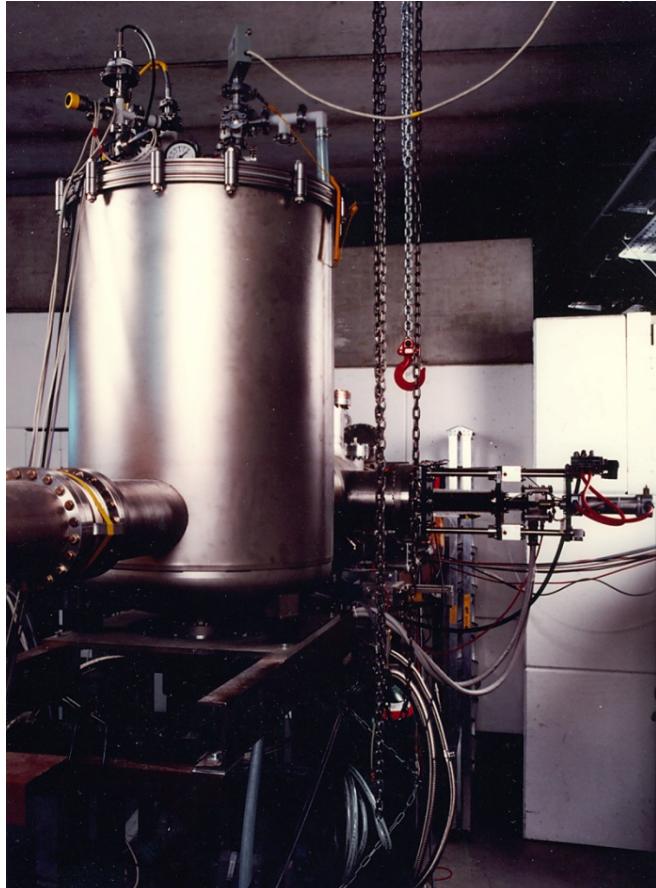
The CCC at GSI Darmstadt



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Photography of the CCC assembled in the beam line and some technical details.

Beam measurement $^{28}\text{Ni}^{26+}$ at 600 MeV/u

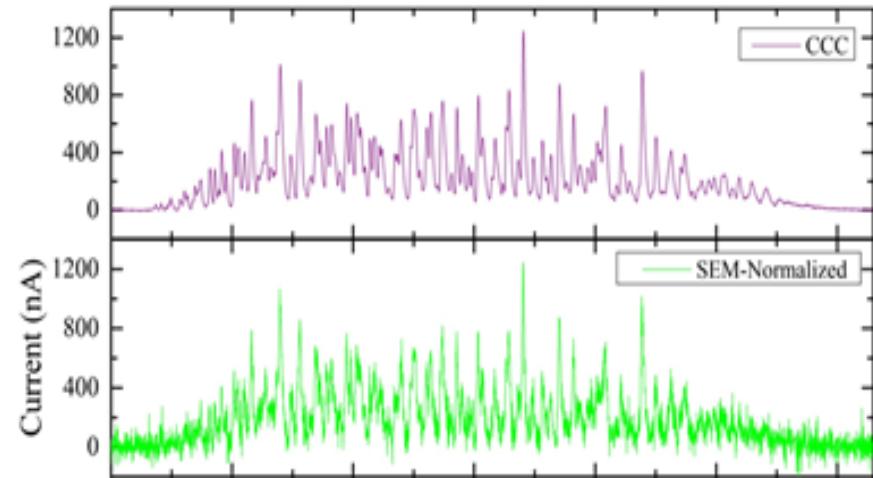


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- Replacement of
 - SQUID-sensor
 - SQUID-electronics
- Secondary Electron Emission Monitor (SEM) for comparison
- Perfect agreement between two independent spill monitors (CCC vs. SEM)



Ni^{26+} at 600 MeV/u extracted from SIS18

CCC for FAIR

Improvements using new core materials and concepts



Improved pick-up coil



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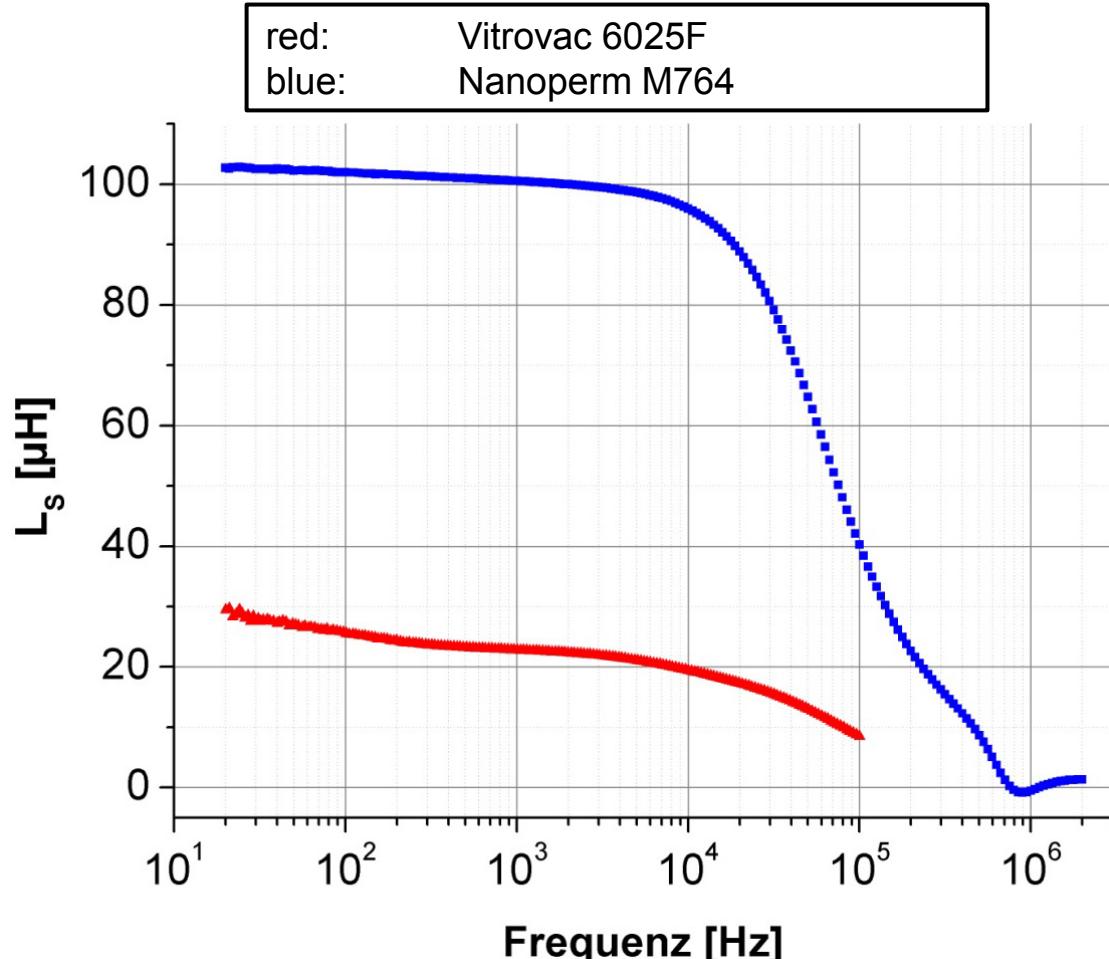


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$$\langle I^2 \rangle = 4k_B T \int \frac{R_s(v)}{(2\pi v L_s(v))^2 + (R_s(v))^2} dv$$

Requirements to core materials:

- frequency independent high real part of the permeability (L_s).
- low imaginary part over a wide frequency range which corresponds to a low losses in the material (R_s).



Improved pick-up coil



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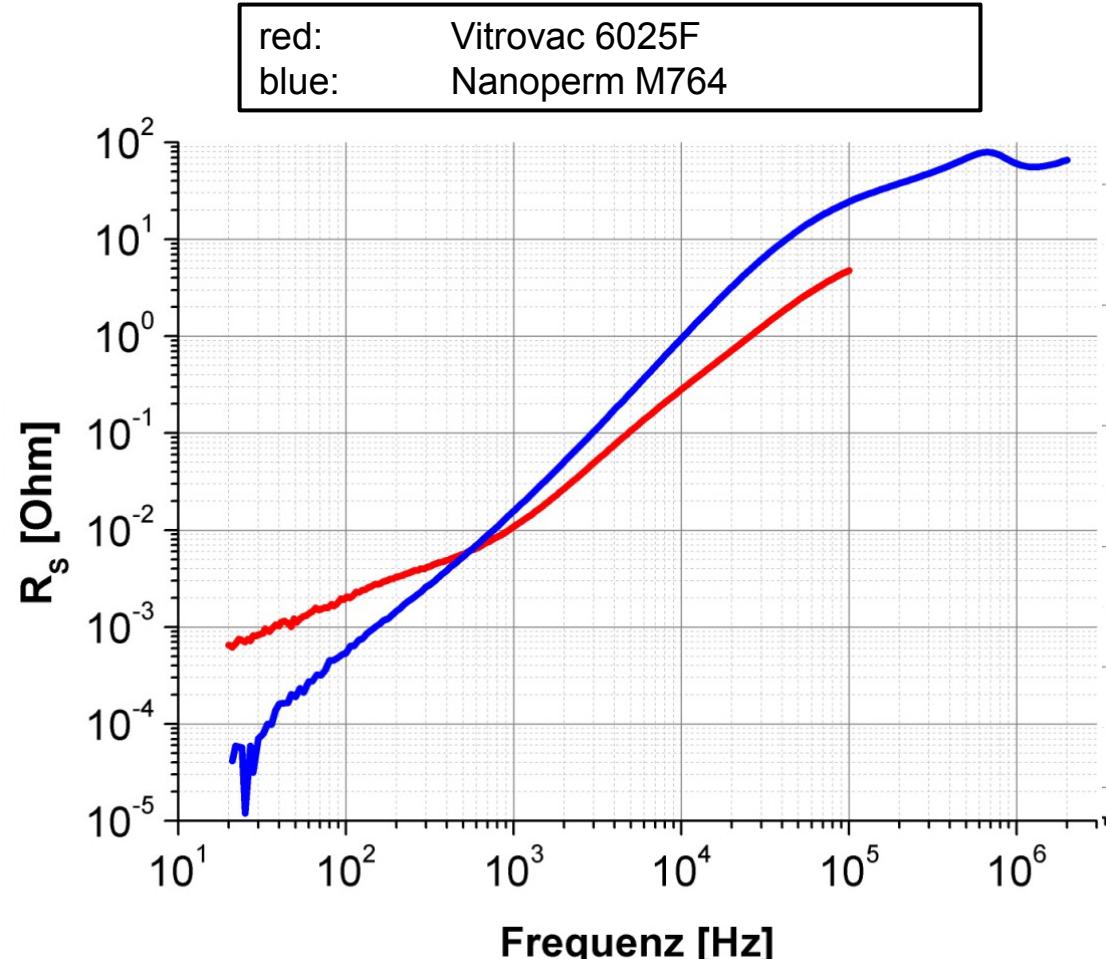


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Setup FAIR-CCC

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- Nanocrystalline Nanoperm M764 as core material
- Electron beam welded niobium parts
- Commercial SQUID-sensor Supracon CP2 blue.
- Commercial SQUID electronics Magnicon XXF-1



Setup FAIR-CCC

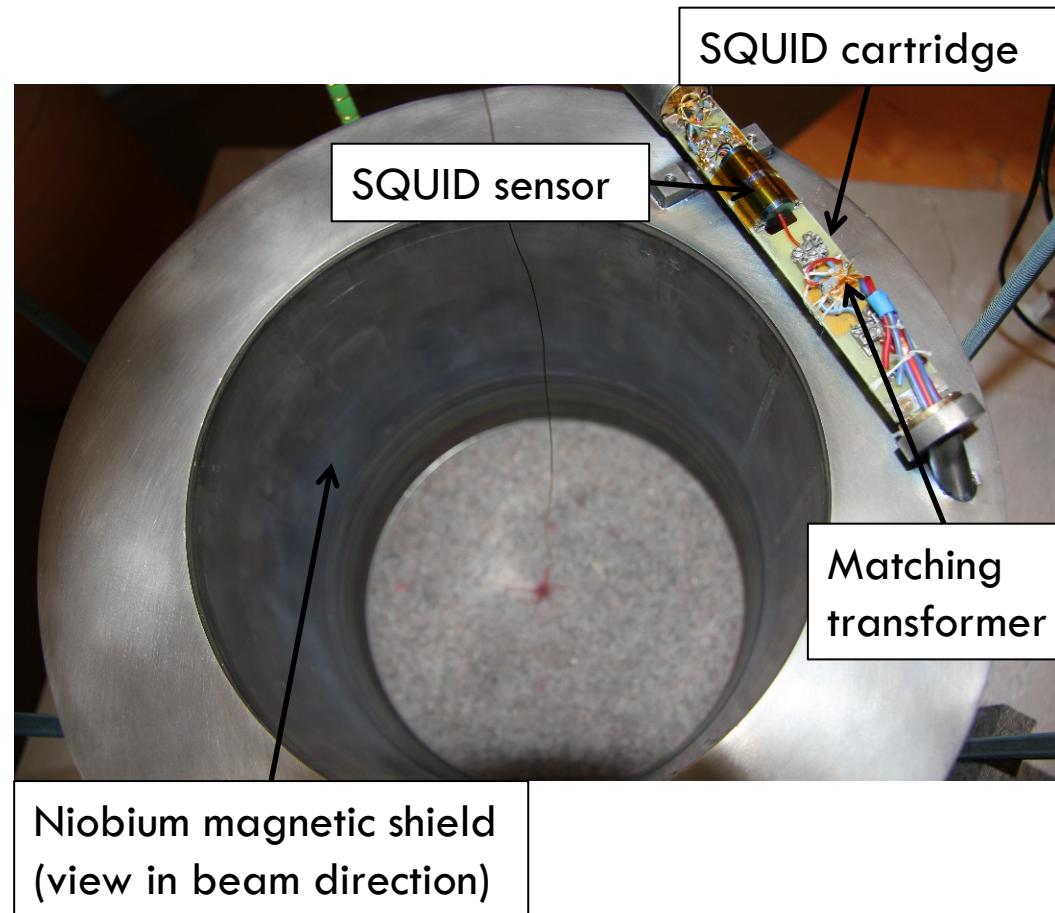
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Current noise density Bandwidth estimation

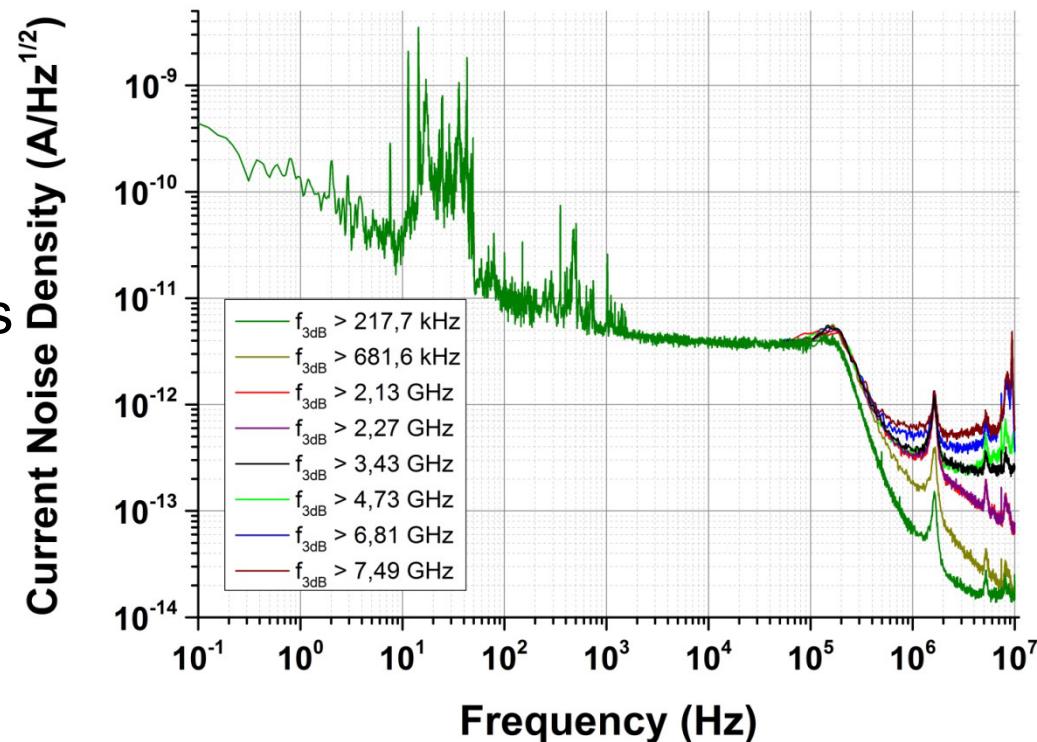
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- White noise $3.5 \text{ pA}/\text{Hz}^{1/2}$
- 3 nA total noise
- SQUID system bandwidth $f_{3\text{dB}}$ adjusted by electronics settings
- Decrease at 200 kHz estimated as CCC bandwidth



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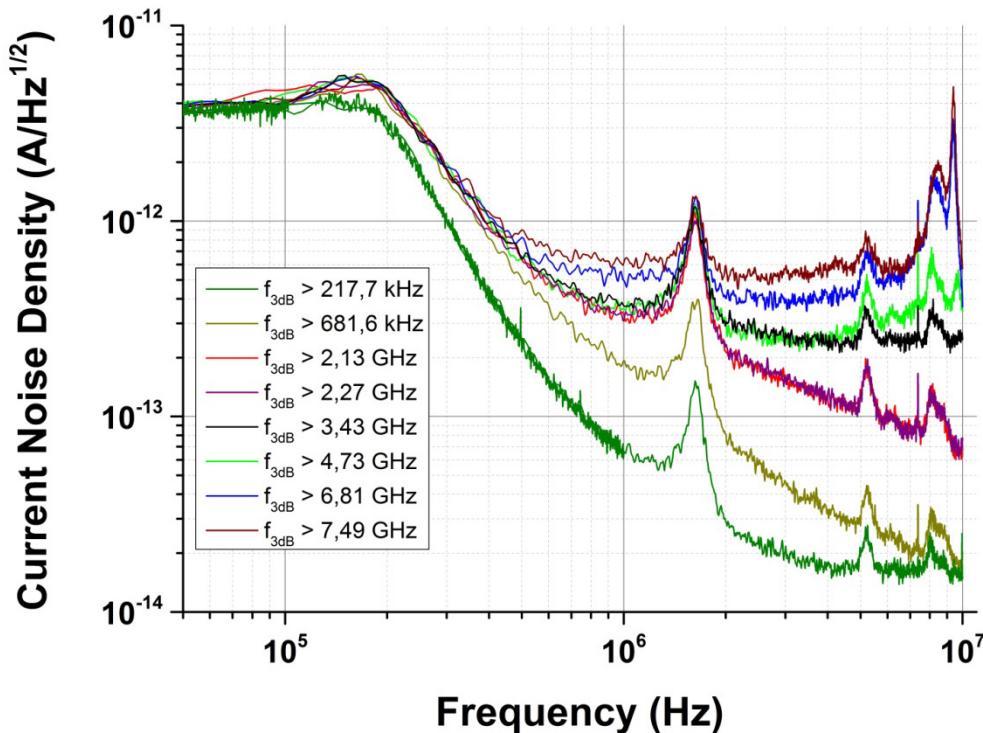
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Current noise density Bandwidth estimation

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Step function response

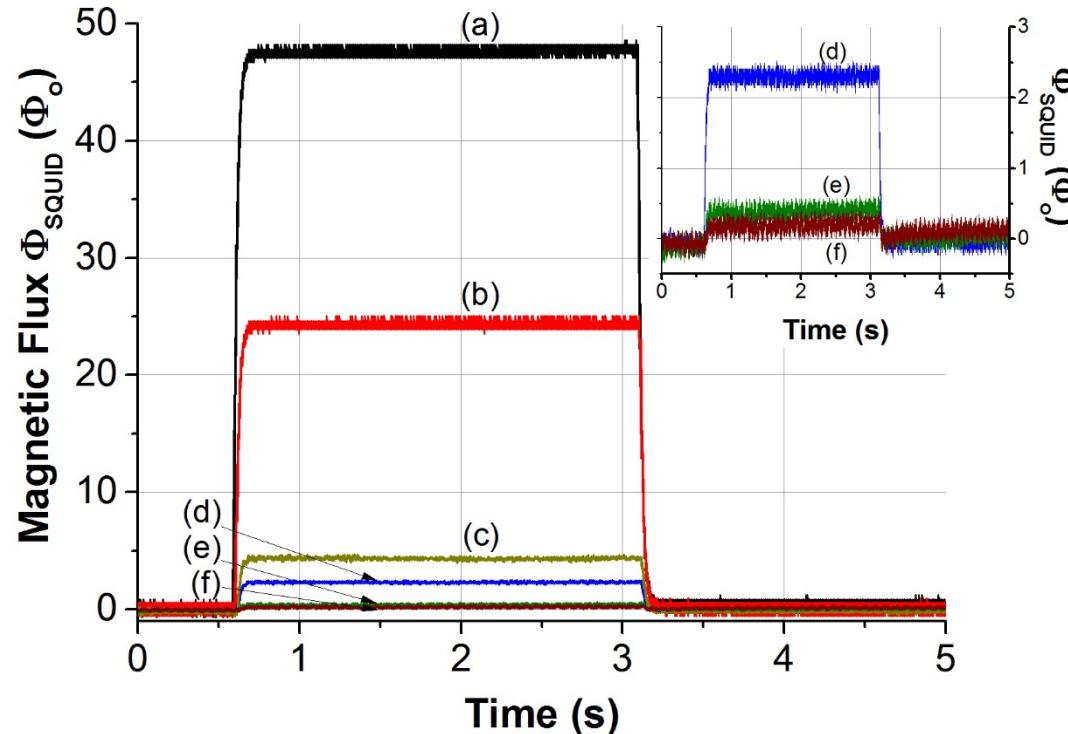
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Tests with battery powered current source

(a) 2 μA , (b) 1 μA , (c) 200 nA, (d) 100 nA, (e) 20 nA, (f) 10 nA

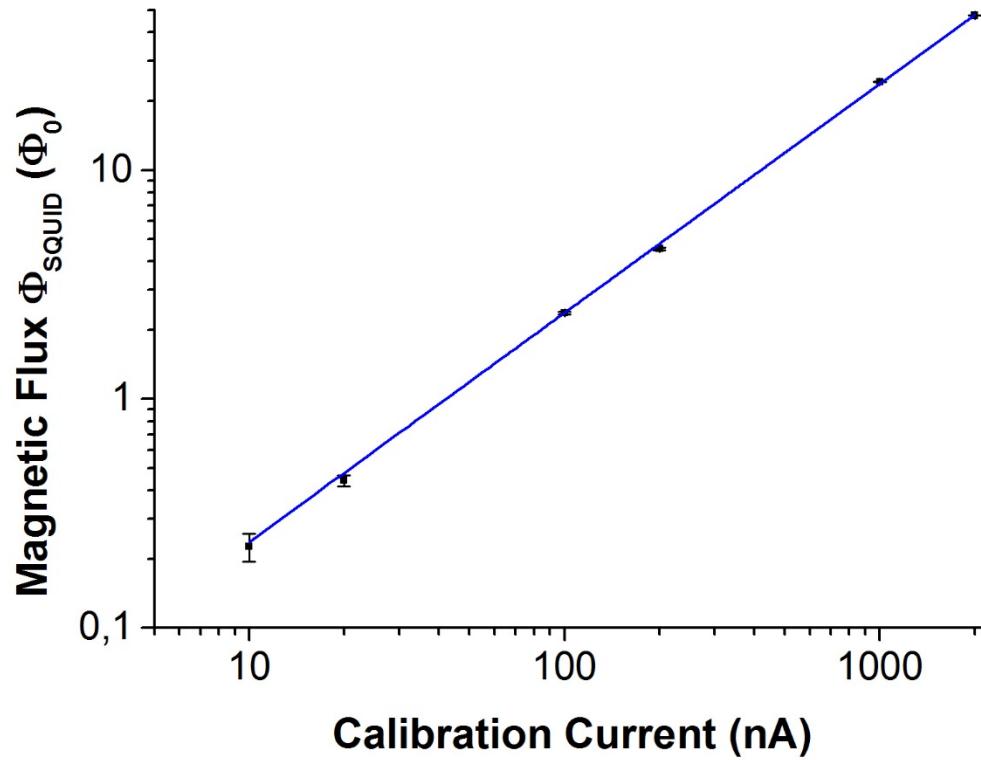
Current sensitivity

Linearity

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$$\text{Current sensitivity} = 42.0 \pm 0.3 \text{ nA}/\Phi_0$$

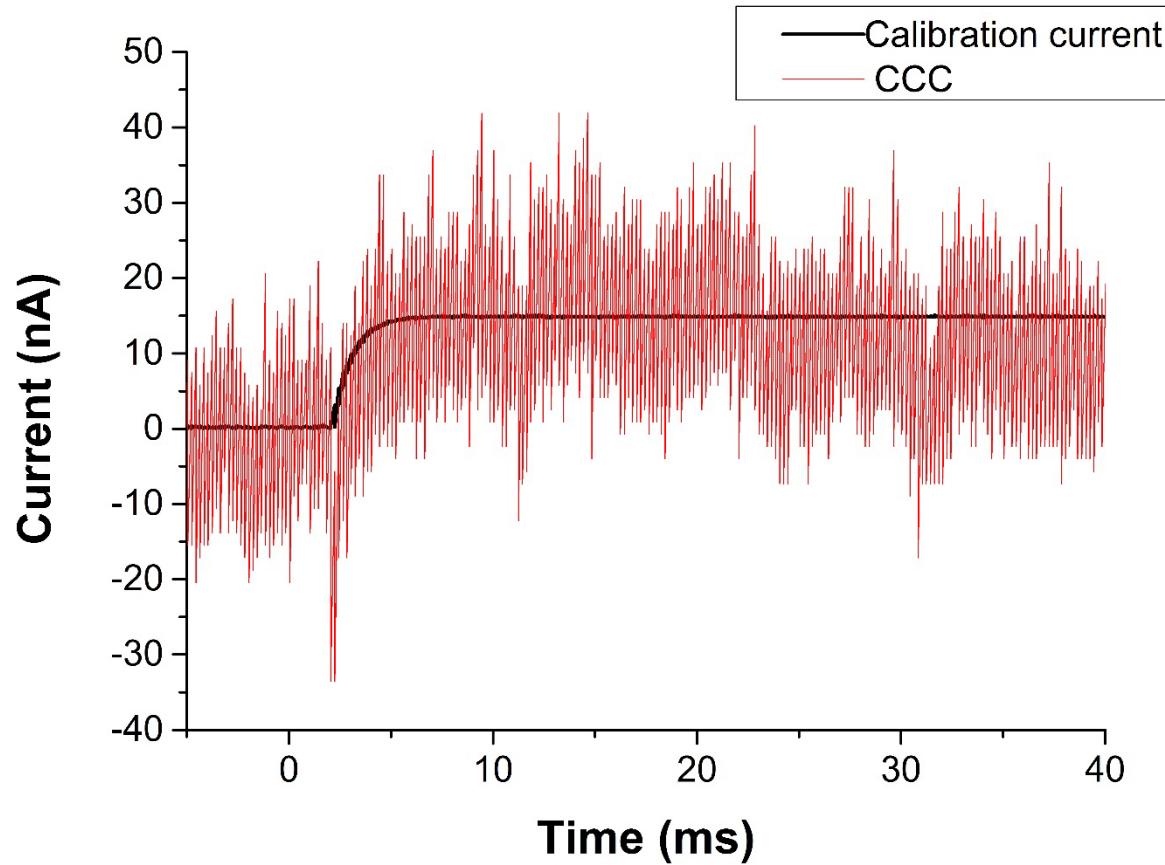
Slew rate limitation



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(black) 14 nA test signal with low signal slew rate
(red) CCC response

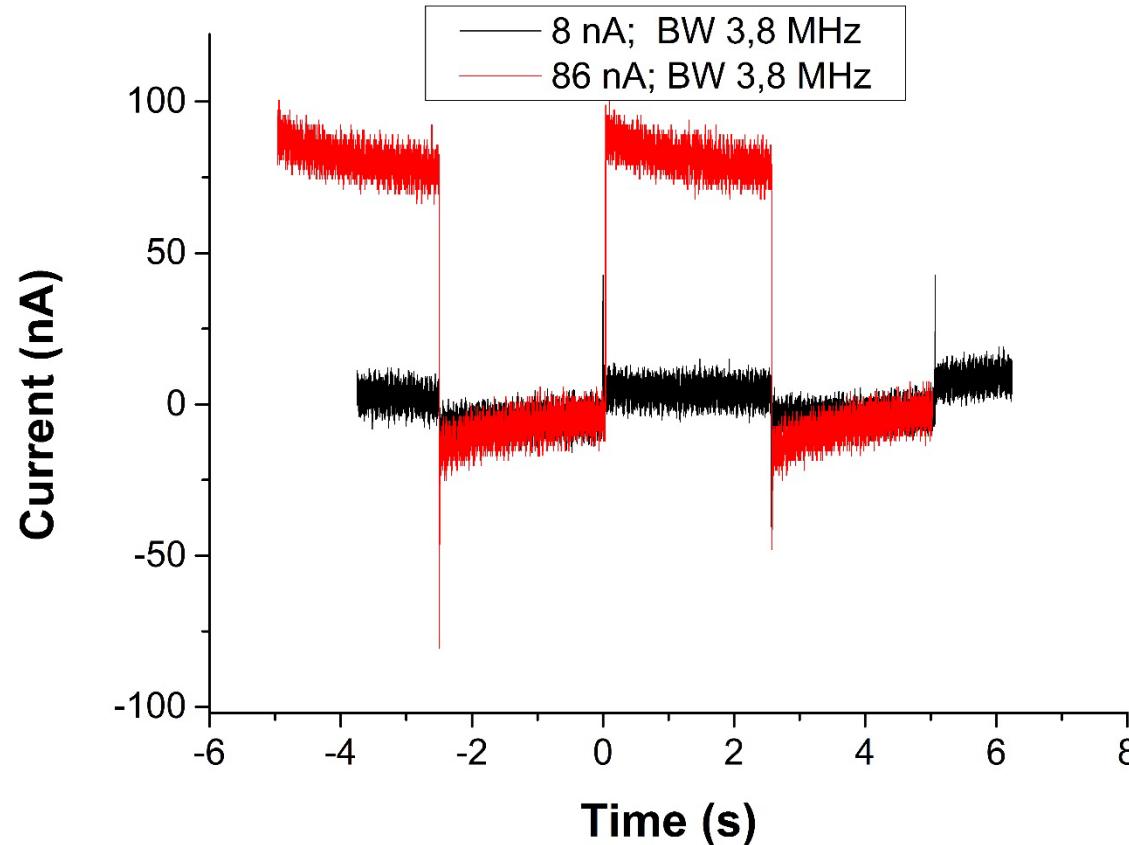
Slew rate limitation



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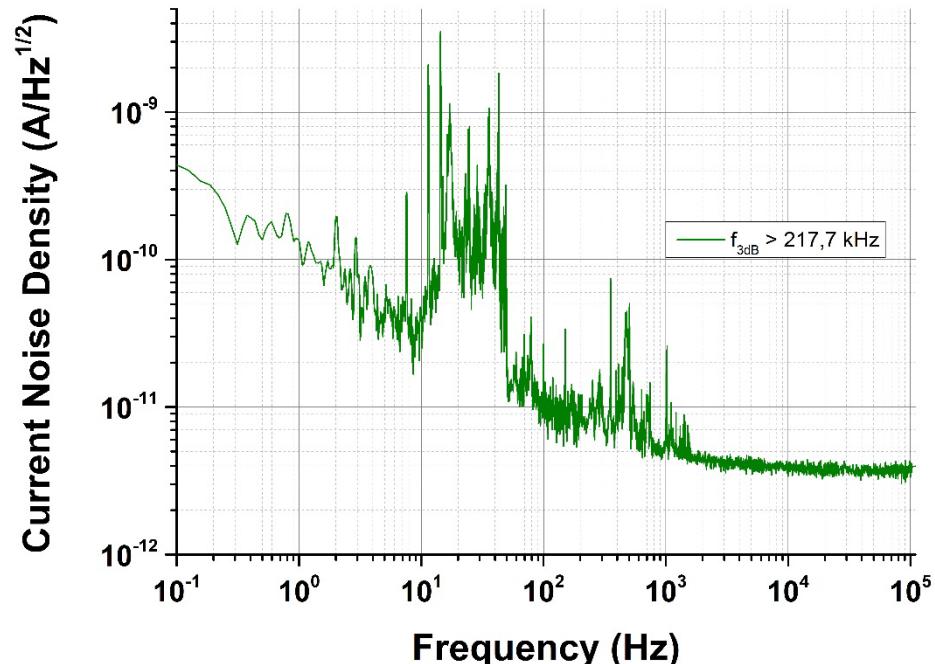


CCC response on a 8 nA (black) and 86 nA (red) test signal with high signal slew rate

Future Investigations

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- Investigations on microphonic effects
- Development of cryostat with local liquid helium supply
 - Reducing microphonic effects by damping of mechanical vibrations, pressure and temperature stabilization



Advantages of a SQUID based CCC



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- Non-destructive measurement method
- Measurement of the absolute values of the current
- Exact absolute calibration using an additional wire loop
- Independency of charged particle trajectories and particle energies
- Demonstration of the suitability at GSI and HoBiCat
- High resolution ($< 100 \text{ pA}/\sqrt{\text{Hz}}$), $3.5 \text{ pA}/\sqrt{\text{Hz}}$ white noise
- High bandwidth of 200 kHz estimated
- High linearity

Acknowledgement



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